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What is "Embedded - Microcontrollers"?

"Embedded - Microcontrollers" refer to small, integrated circuits designed to perform specific tasks within larger systems. These microcontrollers are essentially compact computers on a single chip, containing a processor core, memory, and programmable input/output peripherals. They are called "embedded" because they are embedded within electronic devices to control various functions, rather than serving as standalone computers. Microcontrollers are crucial in modern electronics, providing the intelligence and control needed for a wide range of applications.

Applications of "<u>Embedded - Microcontrollers</u>"

Details	
Product Status	Active
Core Processor	M8C
Core Size	8-Bit
Speed	24MHz
Connectivity	I ² C, SPI, UART/USART
Peripherals	POR, PWM, WDT
Number of I/O	24
Program Memory Size	16KB (16K x 8)
Program Memory Type	FLASH
EEPROM Size	-
RAM Size	256 x 8
/oltage - Supply (Vcc/Vdd)	3V ~ 5.25V
Data Converters	A/D 4x14b; D/A 4x9b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 85°C (TA)
Mounting Type	Surface Mount
Package / Case	28-SSOP (0.209", 5.30mm Width)
Supplier Device Package	28-SSOP
Purchase URL	https://www.e-xfl.com/product-detail/infineon-technologies/cy8c27443-24pvxit



The digital blocks can be connected to any GPIO through a series of global buses that can route any signal to any pin. The buses also enable signal multiplexing and for performing logic operations. This configurability frees your designs from the constraints of a fixed peripheral controller.

Digital blocks are provided in rows of four, where the number of blocks varies by PSoC device family. This lets you the optimum choice of system resources for your application. Family resources are shown in the table titled PSoC Device Characteristics on page 6.

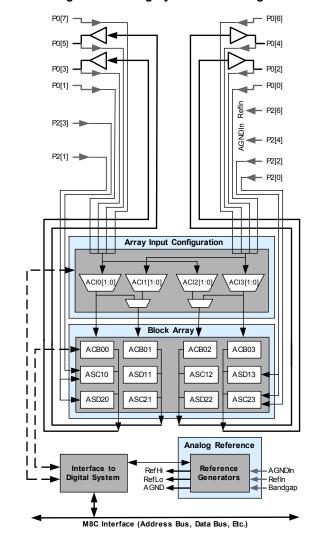
Analog System

The analog system is composed of 12 configurable blocks, each comprised of an opamp circuit allowing the creation of complex analog signal flows. Analog peripherals are very flexible and can be customized to support specific application requirements. Some of the more common PSoC analog functions (most available as user modules) are as follows:

- ADCs (up to 4, with 6- to 14-bit resolution, selectable as incremental, delta sigma, and SAR)
- Filters (2, 4, 6, and 8 pole band pass, low pass, and notch)
- Amplifiers (up to four, with selectable gain to 48x)
- Instrumentation amplifiers (up to two, with selectable gain to 93x)
- Comparators (up to four, with 16 selectable thresholds)
- DACs (up to four, with 6- to 9-bit resolution)
- Multiplying DACs (up to four, with 6- to 9-bit resolution)
- High current output drivers (four with 30 mA drive as a core resource)
- 1.3-V reference (as a system resource)
- DTMF dialer
- Modulators
- Correlators
- Peak detectors
- Many other topologies possible

Analog blocks are provided in columns of three, which includes one continuous time (CT) and two switched capacitor (SC) blocks, as shown in the following figure.

Figure 3. Analog System Block Diagram



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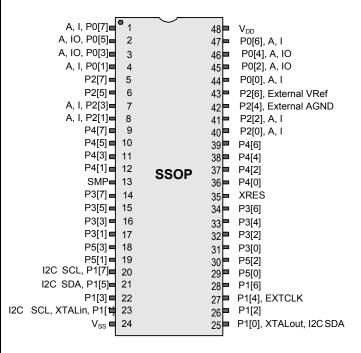


48-pin Part Pinout

Table 6. Pin Definitions – 48-pin Part Pinout (SSOP)

Pin	Τv	ре	Pin	
No.	Digital	Analog	Name	Description
1	I/O	I	P0[7]	Analog column mux input
2	I/O	I/O	P0[5]	Analog column mux input and column output
3	I/O	I/O	P0[3]	Analog column mux input and column output
4	I/O	I	P0[1]	Analog column mux input
5	I/O		P2[7]	
6	I/O		P2[5]	
7	I/O	I	P2[3]	Direct switched capacitor block input
8	I/O	I	P2[1]	Direct switched capacitor block input
9	I/O		P4[7]	
10	I/O		P4[5]	
11	I/O		P4[3]	
12	I/O		P4[1]	
13	Po	wer	SMP	SMP connection to external components required
14	I/O		P3[7]	
15	I/O		P3[5]	
16	I/O		P3[3]	
17	I/O		P3[1]	
18	I/O		P5[3]	
19	I/O		P5[1]	
20	I/O		P1[7]	I ² C SCL
21	I/O		P1[5]	I ² C SDA
22	I/O		P1[3]	
23	I/O		P1[1]	Crystal Input (XTALin), I ² C SCL, ISSP-SCLK ^[9]
24	Po	wer	Vss	Ground connection
25	I/O		P1[0]	Crystal output (XTALout), I ² C SDA, ISSP-SDATA. [9]
26	I/O		P1[2]	
27	I/O		P1[4]	Optional external clock input (EXTCLK)
28	I/O		P1[6]	
29	I/O		P5[0]	
30	I/O		P5[2]	
31	1/0		P3[0]	
32	I/O		P3[2]	
33	I/O		P3[4]	
34	I/O		P3[6]	
35	ln	put	XRES	Active high external reset with internal pull down
36	I/O		P4[0]	
37	I/O		P4[2]	
38	I/O		P4[4]	
39	I/O		P4[6]	
40	I/O	I	P2[0]	Direct switched capacitor block input
41	I/O	I	P2[2]	Direct switched capacitor block input
42	I/O		P2[4]	External analog ground (AGND)
43	I/O		P2[6]	External voltage reference (VRef)
44	I/O	ı	P0[0]	Analog column mux input
45	I/O	I/O	P0[2]	Analog column mux input and column output
46	I/O	I/O	P0[4]	Analog column mux input and column output
47	I/O	I	P0[6]	Analog column mux input
48	Po	wer	V_{DD}	Supply voltage

Figure 8. CY8C27643 48-pin PSoC Device



LEGEND: A = Analog, I = Input, and O = Output.

Note

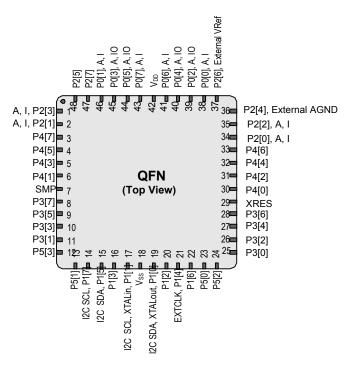
^{9.} These are the ISSP pins, which are not High Z at POR (Power On Reset). See the PSoC Programmable System-on-Chip Technical Reference Manual for details.



Table 7. Pin Definitions – 48-pin Part Pinout (QFN)

				- 46-pin Part Pinout (QFN)					
Pin No.	Digital	pe Analog	Pin Name	Description					
1	I/O	Allalog	P2[3]	Direct switched capacitor block input					
2	1/0	i	P2[1]	Direct switched capacitor block input					
3	I/O		P4[7]	Direct Switched capacitor block input					
4	I/O		P4[5]						
5	I/O		P4[3]						
6	I/O		P4[1]						
7	Pov	ver	SMP	SMP connection to external components					
•			· · · · ·	required					
8	I/O		P3[7]						
9	I/O		P3[5]						
10	I/O		P3[3]						
11	I/O		P3[1]						
12	I/O		P5[3]						
13	I/O		P5[1]						
14	I/O		P1[7]	I ² C SCL					
15	I/O		P1[5]	I ² C SDA					
16	I/O		P1[3]						
17	I/O		P1[1]	Crystal input (XTALin), I ² C SCL, ISSP-SCLK ^[11]					
18	Pov	wer	Vss	Ground connection.					
19	I/O		P1[0]	Crystal output (XTALout), I ² C SDA, ISSP-SDATA ^[11]					
20	I/O		P1[2]						
21	I/O		P1[4]	Optional external clock input (EXTCLK)					
22	I/O		P1[6]						
23	I/O		P5[0]						
24	I/O		P5[2]						
25	I/O		P3[0]						
26	I/O		P3[2]						
27	I/O		P3[4]						
28	I/O		P3[6]						
29	Inp	out	XRES	Active high external reset with internal pull down					
30	I/O		P4[0]						
31	I/O		P4[2]						
32	I/O		P4[4]						
33	I/O		P4[6]						
34	I/O	ı	P2[0]	Direct switched capacitor block input					
35	I/O	I	P2[2]	Direct switched capacitor block input					
36	1/0		P2[4]	External analog ground (AGND)					
37	I/O		P2[6]	External voltage reference (V _{REF})					
38	I/O	ı	P0[0]	Analog column mux input					
39	1/0	I/O	P0[2]	Analog column mux input and column output					
40	I/O	I/O	P0[4]	Analog column mux input and column output					
41	I/O	I	P0[6]	Analog column mux input					
42	Pov	wer	V_{DD}	Supply voltage					
43	I/O	I	P0[7]	Analog column mux input					
44	I/O	I/O	P0[5]	Analog column mux input and column output					
45	I/O	I/O	P0[3]	Analog column mux input and column output					
46	I/O	I	P0[1]	Analog column mux input					
47	I/O		P2[7]						
48	I/O		P2[5]						
				I .					

Figure 9. CY8C27643 48-pin PSoC Device^[10]



LEGEND: A = Analog, I = Input, and O = Output.

Notes

^{10.} The QFN package has a center pad that must be connected to ground (Vss).

11. These are the ISSP pins, which are not High Z at POR (Power On Reset). See the PSoC Technical Reference Manual for details.



56-pin Part Pinout

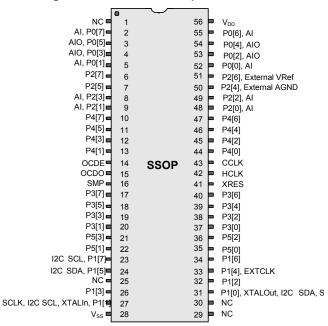
The 56-pin SSOP part is for the CY8C27002 On-Chip Debug (OCD) PSoC device.

Note This part is only used for in-circuit debugging. It is NOT available for production.

Table 8. Pin Definitions – 56-pin Part Pinout (SSOP)

Pin		/pe	Pin	n						
No.	Digital	Analog	Name	Description						
1			NC	No connection. Pin must be left floating						
2	1/0	I	P0[7]	Analog column mux input						
3	I/O	I	P0[5]	Analog column mux input and column output						
4	I/O	ı	P0[3]	Analog column mux input and column output						
5	I/O	I	P0[1]	Analog column mux input						
6	I/O		P2[7]							
7	I/O		P2[5]							
8	I/O	I	P2[3]	Direct switched capacitor block input						
9	I/O	I	P2[1]	Direct switched capacitor block input						
10	I/O		P4[7]							
11	I/O		P4[5]							
12	I/O	I	P4[3]							
13	I/O	I	P4[1]							
14	OCD		OCDE	OCD even data I/O						
15	OCD		OCDO	OCD odd data output						
16	Po	wer	SMP	SMP connection to required external components						
17	I/O		P3[7]							
18	I/O		P3[5]							
19	I/O		P3[3]							
20	I/O		P3[1]							
21	I/O		P5[3]							
22	I/O		P5[1]							
23	I/O		P1[7]	I ² C SCL						
24	I/O		P1[5]	I ² C SDA						
25		<u>I</u>	NC	No connection. Pin must be left floating						
26	I/O		P1[3]	_						
27	I/O		P1[1]	Crystal Input (XTALin), I ² C SCL, ISSP-SCLK ^[12]						
28	Po	wer	V_{DD}	Supply voltage						
29			NC	No connection. Pin must be left floating						
30			NC	No connection. Pin must be left floating						
31	I/O		P1[0]	Crystal output (XTALout), I ² C SDA, ISSP-SDATA ^[12]						
32	I/O		P1[2]							
33	I/O		P1[4]	Optional external clock input (EXTCLK)						
34	I/O		P1[6]	-						
35	I/O		P5[0]							
36	I/O		P5[2]							
37	I/O		P3[0]							
38	I/O		P3[2]							
39	I/O		P3[4]							
40	I/O		P3[6]							

Figure 10. CY8C27002 56-pin PSoC Device



Not for Production

Note

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^{12.} These are the ISSP pins, which are not High Z at POR (Power On Reset). See the PSoC Programmable System-on-Chip Technical Reference Manual for details.



Electrical Specifications

This section presents the DC and AC electrical specifications of the CY8C27x43 PSoC device. For the most up to date electrical specifications, confirm that you have the most recent datasheet by going to the web at http://www.cypress.com.

Specifications are valid for –40 °C \leq T $_A$ \leq 85 °C and T $_J$ \leq 100 °C, except where noted. Specifications for devices running at greater than 12 MHz are valid for –40 °C \leq T $_A$ \leq 70 °C and T $_J$ \leq 82 °C.

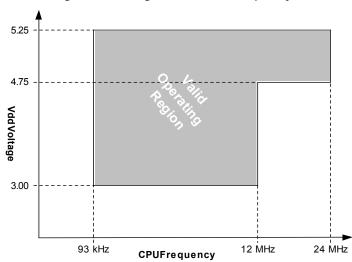


Figure 11. Voltage versus CPU Frequency

Absolute Maximum Ratings

Exceeding maximum ratings may shorten the useful life of the device. User guidelines are not tested.

Table 12. Absolute Maximum Ratings

Symbol	Description	Min	Тур	Max	Unit	Notes
T _{STG}	Storage temperature	- 55	25	+100	°C	Higher storage temperatures reduce data retention time. Recommended storage temperature is +25 °C ± 25 °C. Extended duration storage temperatures above 65 °C degrade reliability.
T _{BAKETEMP}	Bake temperature	_	125	See package label	°C	
t _{BAKETIME}	Bake time	See package label	-	72	Hours	
T _A	Ambient temperature with power applied	-40	-	+85	°C	
V_{DD}	Supply voltage on V _{DD} relative to Vss	-0.5	-	+6.0	V	
V_{IO}	DC input voltage	Vss - 0.5	-	V _{DD} + 0.5	V	
V_{IOZ}	DC voltage applied to tristate	Vss - 0.5	-	V _{DD} + 0.5	V	
I _{MIO}	Maximum current into any port pin	-25	_	+50	mA	
I _{MAIO}	Maximum current into any port pin configured as analog driver	-50	_	+50	mA	
ESD	Electrostatic discharge voltage	2000	_	-	V	Human body model ESD.
LU	Latch-up current	-	-	200	mA	

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Table 17. 3.3-V DC Operational Amplifier Specifications (continued)

Symbol	Description	Min	Тур	Max	Unit	Notes
V _{OHIGHOA}	High output voltage swing (internal signals) Power = low, Opamp bias = low Power = medium, Opamp bias = low Power = high, Opamp bias = low	V _{DD} - 0.2 V _{DD} - 0.2 V _{DD} - 0.2	- - -	- - -	V V	Power = high, Opamp bias = high setting is not allowed for 3.3 V V _{DD} operation.
V _{OLOWOA}	Low output voltage swing (internal signals) Power = low, Opamp bias = low Power = medium, Opamp bias = low Power = high, Opamp bias = low	- - -	_ _ _	0.2 0.2 0.2	V V V	Power = high, Opamp bias = high setting is not allowed for 3.3 V V _{DD} operation.
Isoa	Supply current (including associated AGND buffer) Power = low, Opamp bias = low Power = low, Opamp bias = high Power = medium, Opamp bias = low Power = medium, Opamp bias = high Power = high, Opamp bias = low Power = high, Opamp bias = high	- - - - -	150 300 600 1200 2400	200 400 800 1600 3200	µА µА µА µА µА	Power = high, Opamp bias = high setting is not allowed for 3.3 V V _{DD} operation.
PSRR _{OA}	Supply voltage rejection ratio	50	80	ı	dB	$V_{SS} \le V_{IN} \le (V_{DD} - 2.25)$ or $(V_{DD} - 1.25 \text{ V}) \le V_{IN} \le V_{DD}$.

DC Low-Power Comparator Specifications

Table 18 lists guaranteed maximum and minimum specifications for the voltage and temperature ranges: 4.75 V to 5.25 V and $-40~^{\circ}\text{C} \le \text{T}_{\text{A}} \le 85~^{\circ}\text{C}$, 3.0~V to 3.6~V and $-40~^{\circ}\text{C} \le \text{T}_{\text{A}} \le 85~^{\circ}\text{C}$, or 2.4~V to 3.0~V and $-40~^{\circ}\text{C} \le \text{T}_{\text{A}} \le 85~^{\circ}\text{C}$, respectively. Typical parameters apply to 5~V at $25~^{\circ}\text{C}$ and are for design guidance only.

Table 18. DC Low-Power Comparator Specifications

Symbol	Description	Min	Тур	Max	Unit
V _{REFLPC}	Low-power comparator (LPC) reference voltage range	0.2	_	V _{DD} – 1	V
I _{SLPC}	LPC supply current	_	10	40	μА
V _{OSLPC}	LPC voltage offset	-	2.5	30	mV

DC Analog Output Buffer Specifications

Table 19 and Table 20 on page 24 list guaranteed maximum and minimum specifications for the voltage and temperature ranges: 4.75 V to 5.25 V and $-40 \text{ °C} \leq T_A \leq 85 \text{ °C}$, or 3.0 V to 3.6 V and $-40 \text{ °C} \leq T_A \leq 85 \text{ °C}$, respectively. Typical parameters apply to 5 V and 3.3 V at 25 °C and are for design guidance only.

Table 19. 5-V DC Analog Output Buffer Specifications

Symbol	Description	Min	Тур	Max	Unit	Notes
V _{OSOB}	Input offset voltage (absolute value) Power = low, Opamp bias = low Power = low, Opamp bias = high Power = high, Opamp bias = low Power = high, Opamp bias = high	1 1 1	3 3 3 3	19 19 19 19	mV mV mV	
TCV _{OSOB}	Average input offset voltage drift	_	5	30	μV/°C	
V _{CMOB}	Common-mode input voltage range	0.5	_	V _{DD} – 1.0	V	
R _{OUTOB}	Output resistance Power = low Power = high	- -	1 1	<u>-</u>	Ω	
V _{OHIGHOB}	High output voltage swing (Load = 32 ohms to V _{DD} /2) Power = low Power = high	0.5 × V _{DD} + 1.3 0.5 × V _{DD} + 1.3		<u>-</u>	V V	
V_{OLOWOB}	Low output voltage swing (Load = 32 ohms to V _{DD} /2)	_	_	_		
	Power = low	_	_	0.5 × V _{DD} – 1.3	V	
	Power = high	_	-	$0.5 \times V_{DD} - 1.3$	V	

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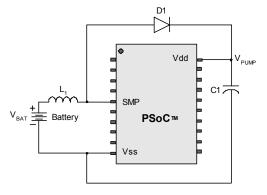
DC Switch Mode Pump Specifications

Table 21 lists guaranteed maximum and minimum specifications for the voltage and temperature ranges: 4.75 V to 5.25 V and $-40~^{\circ}\text{C} \le T_{A} \le 85~^{\circ}\text{C}$, or 3.0 V to 3.6 V and $-40~^{\circ}\text{C} \le T_{A} \le 85~^{\circ}\text{C}$, respectively. Typical parameters apply to 5 V and 3.3 V at 25 $^{\circ}\text{C}$ and are for design guidance only.

Table 21. DC Switch Mode Pump (SMP) Specifications

Symbol	Description	Min	Тур	Max	Unit	Notes
V _{PUMP} 5 V	5 V output voltage	4.75	5.0	5.25	V	Configured as in Note 15. Average, neglecting ripple. SMP trip voltage is set to 5.0 V.
V _{PUMP} 3 V	3 V output voltage	3.00	3.25	3.60	٧	Configured as in Note 15. Average, neglecting ripple. SMP trip voltage is set to 3.25 V.
I _{PUMP}	Available output current $V_{BAT} = 1.5 \text{ V}, V_{PUMP} = 3.25 \text{ V}$ $V_{BAT} = 1.8 \text{ V}, V_{PUMP} = 5.0 \text{ V}$	8 5	_ _	_ _	mA mA	Configured as in Note 15. SMP trip voltage is set to 3.25 V. SMP trip voltage is set to 5.0 V.
V _{BAT} 5 V	Input voltage range from battery	1.8	-	5.0	V	Configured as in Note 15. SMP trip voltage is set to 5.0 V.
V _{BAT} 3 V	Input voltage range from battery	1.0	-	3.3	V	Configured as in Note 15. SMP trip voltage is set to 3.25 V.
V _{BATSTART}	Minimum input voltage from battery to start pump	1.1	-	_	V	Configured as in Note 15.
ΔV_{PUMP_Line}	Line regulation (over V _{BAT} range)	-	5	_	%V _O	Configured as in Note 15. $V_{\rm O}$ is the " $V_{\rm DD}$ Value for PUMP Trip" specified by the VM[2:0] setting in the DC POR and LVD Specification, Table 25 on page 33.
ΔV _{PUMP_Load}	Load regulation	-	5	_	%V _O	Configured as in Note 15. $V_{\rm O}$ is the " $V_{\rm DD}$ Value for PUMP Trip" specified by the VM[2:0] setting in the DC POR and LVD Specification, Table 25 on page 33.
ΔV_{PUMP_Ripple}	Output voltage ripple (depends on capacitor/load)	_	100	_	mVpp	Configured as in Note 15. Load is 5 mA.
E ₃	Efficiency	35	50	_	%	Configured as in Note 15. Load is 5 mA. SMP trip voltage is set to 3.25 V.
F _{PUMP}	Switching frequency	ı	1.3	_	MHz	
DC _{PUMP}	Switching duty cycle	_	50	_	%	

Figure 12. Basic Switch Mode Pump Circuit



Note

15. L_1 = 2 mH inductor, C_1 = 10 mF capacitor, D_1 = Schottky diode. See Figure 12.

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Table 22. 5-V DC Analog Reference Specifications (continued)

Reference ARF_CR [5:3]	Reference Power Settings	Symbol	Reference	Description	Min	Тур	Max	Unit
	RefPower = high Opamp bias = high	V _{REFHI}	Ref High	P2[4] + P2[6] (P2[4] = V _{DD} /2, P2[6] = 1.3 V)	P2[4] + P2[6] - 0.085	P2[4] + P2[6] – 0.016	P2[4] + P2[6] + 0.044	V
<u> </u>		V_{AGND}	AGND	P2[4]	P2[4]	P2[4]	P2[4]	_
		V _{REFLO}	Ref Low	P2[4] – P2[6] (P2[4] = V _{DD} /2, P2[6] = 1.3 V)	P2[4] – P2[6] – 0.022	P2[4] – P2[6] + 0.010	P2[4] – P2[6] + 0.055	V
	RefPower = high Opamp bias = low	V _{REFHI}	Ref High	P2[4] + P2[6] (P2[4] = V _{DD} /2, P2[6] = 1.3 V)	P2[4] + P2[6] - 0.077	P2[4] + P2[6] – 0.010	P2[4] + P2[6] + 0.051	V
 		V_{AGND}	AGND	P2[4]	P2[4]	P2[4]	P2[4]	-
0b001		V _{REFLO}	Ref Low	P2[4] – P2[6] (P2[4] = V _{DD} /2, P2[6] = 1.3 V)	P2[4] – P2[6] – 0.022	P2[4] – P2[6] + 0.005	P2[4] – P2[6] + 0.039	V
	RefPower = medium Opamp bias = high	V _{REFHI}	Ref High	P2[4] + P2[6] (P2[4] = V _{DD} /2, P2[6] = 1.3 V)	P2[4] + P2[6] - 0.070	P2[4] + P2[6] - 0.010	P2[4] + P2[6] + 0.050	V
 		V_{AGND}	AGND	P2[4]	P2[4]	P2[4]	P2[4]	-
		V _{REFLO}	Ref Low	P2[4] – P2[6] (P2[4] = V _{DD} /2, P2[6] = 1.3 V)	P2[4] – P2[6] – 0.022	P2[4] – P2[6] + 0.005	P2[4] – P2[6] + 0.039	V
	RefPower = medium Opamp bias = low	V _{REFHI}	Ref High	P2[4] + P2[6] (P2[4] = V _{DD} /2, P2[6] = 1.3 V)	P2[4] + P2[6] - 0.070	P2[4] + P2[6] - 0.007	P2[4] + P2[6] + 0.054	V
 		V_{AGND}	AGND	P2[4]	P2[4]	P2[4]	P2[4]	-
		V _{REFLO}	Ref Low	P2[4] – P2[6] (P2[4] = V _{DD} /2, P2[6] = 1.3 V)	P2[4] – P2[6] – 0.022	P2[4] – P2[6] + 0.002	P2[4] – P2[6] + 0.032	V
	RefPower = high	V _{REFHI}	Ref High	V_{DD}	V _{DD} – 0.037	V _{DD} – 0.009	V_{DD}	V
<u> </u>	Opamp bias = high	V_{AGND}	AGND	V _{DD} /2	V _{DD} /2 – 0.061	$V_{DD}/2 - 0.006$	$V_{DD}/2 + 0.047$	V
<u> </u>		V_{REFLO}	Ref Low	V_{SS}	V _{SS}	V _{SS} + 0.007	V _{SS} + 0.028	V
<u> </u>	RefPower = high	V_{REFHI}	Ref High	V_{DD}	V _{DD} – 0.039	$V_{DD} - 0.006$	V_{DD}	V
	Opamp bias = low	V_{AGND}	AGND	V _{DD} /2	V _{DD} /2 – 0.049	V _{DD} /2 – 0.005	$V_{DD}/2 + 0.036$	V
0b010		V_{REFLO}	Ref Low	V _{SS}	V _{SS}	V _{SS} + 0.005	V _{SS} + 0.019	V
	RefPower = medium	V_{REFHI}	Ref High	V_{DD}	V _{DD} – 0.037	V _{DD} – 0.007	V_{DD}	V
ļ	Opamp bias = high	V_{AGND}	AGND	V _{DD} /2	V _{DD} /2 – 0.054	$V_{DD}/2 - 0.005$	$V_{DD}/2 + 0.041$	V
		V_{REFLO}	Ref Low	V _{SS}	V _{SS}	V _{SS} + 0.006	V _{SS} + 0.024	V
	RefPower = medium Opamp bias = low	V_{REFHI}	Ref High	V_{DD}	V _{DD} – 0.042	V _{DD} – 0.005	V_{DD}	V
	Sparrip bias - 10W	V_{AGND}	AGND	V _{DD} /2	V _{DD} /2 – 0.046	$V_{DD}/2 - 0.004$	V _{DD} /2 + 0.034	V
		V _{REFLO}	Ref Low	V _{SS}	V _{SS}	V _{SS} + 0.004	V _{SS} + 0.017	V

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Table 23. 3.3-V DC Analog Reference Specifications

Reference ARF_CR [5:3]	Reference Power Settings	Symbol	Reference	Description	Min	Тур	Max	Unit
		V _{REFHI}	Ref High	V _{DD} /2 + Bandgap	V _{DD} /2 + 1.225	V _{DD} /2 + 1.292	V _{DD} /2 + 1.361	V
	RefPower = high Opamp bias = high	V _{AGND}	AGND	V _{DD} /2	V _{DD} /2 – 0.067	V _{DD} /2 – 0.002	V _{DD} /2 + 0.063	V
		V _{REFLO}	Ref Low	V _{DD} /2 – Bandgap	V _{DD} /2 – 1.35	V _{DD} /2 – 1.293	V _{DD} /2 – 1.210	V
		V_{REFHI}	Ref High	V _{DD} /2 + Bandgap	V _{DD} /2 + 1.218	V _{DD} /2 + 1.294	V _{DD} /2 + 1.370	V
	RefPower = high Opamp bias = low	V _{AGND}	AGND	V _{DD} /2	V _{DD} /2 – 0.038	V _{DD} /2 – 0.001	V _{DD} /2 + 0.035	V
05000		V _{REFLO}	Ref Low	V _{DD} /2 – Bandgap	V _{DD} /2 – 1.329	V _{DD} /2 – 1.296	V _{DD} /2 – 1.259	V
0b000		V_{REFHI}	Ref High	V _{DD} /2 + Bandgap	V _{DD} /2 + 1.221	V _{DD} /2 + 1.294	V _{DD} /2 + 1.366	V
	RefPower = medium Opamp bias = high	V _{AGND}	AGND	V _{DD} /2	V _{DD} /2 – 0.050	V _{DD} /2 – 0.002	V _{DD} /2 + 0.046	V
		V _{REFLO}	Ref Low	V _{DD} /2 – Bandgap	V _{DD} /2 – 1.331	V _{DD} /2 – 1.296	V _{DD} /2 – 1.260	V
		V_{REFHI}	Ref High	V _{DD} /2 + Bandgap	V _{DD} /2 + 1.226	V _{DD} /2 + 1.295	V _{DD} /2 + 1.365	V
	RefPower = medium Opamp bias = low	V _{AGND}	AGND	V _{DD} /2	V _{DD} /2 – 0.028	V _{DD} /2 – 0.001	V _{DD} /2 + 0.025	V
		V _{REFLO}	Ref Low	V _{DD} /2 – Bandgap	V _{DD} /2 – 1.329	V _{DD} /2 – 1.297	V _{DD} /2 – 1.262	V
	RefPower = high Opamp bias = high	V _{REFHI}	Ref High	P2[4]+P2[6] (P2[4] = V _{DD} /2, P2[6] = 0.5 V)	P2[4] + P2[6] - 0.098	P2[4] + P2[6] - 0.018	P2[4] + P2[6] + 0.055	V
		V _{AGND}	AGND	P2[4]	P2[4]	P2[4]	P2[4]	_
		V _{REFLO}	Ref Low	P2[4] – P2[6] (P2[4] = V _{DD} /2, P2[6] = 0.5 V)	P2[4] – P2[6] – 0.055	P2[4] - P2[6] + 0.013	P2[4] - P2[6] + 0.086	V
		V _{REFHI}	Ref High	P2[4] + P2[6] (P2[4] = V _{DD} /2, P2[6] = 0.5 V)	P2[4] + P2[6] – 0.082	P2[4] + P2[6] - 0.011	P2[4] + P2[6] + 0.050	V
	RefPower = high Opamp bias = low	V _{AGND}	AGND	P2[4]	P2[4]	P2[4]	P2[4]	_
0b001		V _{REFLO}	Ref Low	P2[4] – P2[6] (P2[4] = V _{DD} /2, P2[6] = 0.5 V)	P2[4] – P2[6] – 0.037	P2[4] - P2[6] + 0.006	P2[4] - P2[6] + 0.054	V
05001		V _{REFHI}	Ref High	P2[4] + P2[6] (P2[4] = V _{DD} /2, P2[6] = 0.5 V)	P2[4] + P2[6] – 0.079	P2[4] + P2[6] - 0.012	P2[4] + P2[6] + 0.047	V
	RefPower = medium Opamp bias = high	V _{AGND}	AGND	P2[4]	P2[4]	P2[4]	P2[4]	_
		V _{REFLO}	Ref Low	P2[4]–P2[6] (P2[4] = V _{DD} /2, P2[6] = 0.5 V)	P2[4] – P2[6] – 0.038	P2[4] - P2[6] + 0.006	P2[4] - P2[6] + 0.057	V
		V _{REFHI}	Ref High	P2[4]+P2[6] (P2[4] = V _{DD} /2, P2[6] = 0.5 V)	P2[4] + P2[6] - 0.080	P2[4] + P2[6] - 0.008	P2[4] + P2[6] + 0.055	V
	RefPower = medium Opamp bias = low	V _{AGND}	AGND	P2[4]	P2[4]	P2[4]	P2[4]	_
		V _{REFLO}	Ref Low	P2[4]–P2[6] (P2[4] = V _{DD} /2, P2[6] = 0.5 V)	P2[4] – P2[6] – 0.032	P2[4] – P2[6] + 0.003	P2[4] – P2[6] + 0.042	V

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AC Electrical Characteristics

AC Chip-Level Specifications

The following table lists guaranteed maximum and minimum specifications for the voltage and temperature ranges: 4.75 V to 5.25 V and $-40~^{\circ}\text{C} \le T_{A} \le 85~^{\circ}\text{C}$, or 3.0 V to 3.6 V and $-40~^{\circ}\text{C} \le T_{A} \le 85~^{\circ}\text{C}$, respectively. Typical parameters apply to 5 V and 3.3 V at 25 $^{\circ}\text{C}$ and are for design guidance only.

Table 28. AC Chip-Level Specifications

Symbol	Description	Min	Тур	Max	Unit	Notes
F _{IMO}	Internal main oscillator (IMO) frequency	23.4	24	24.6 ^[22]	MHz	Trimmed. Utilizing factory trim values.
F _{CPU1}	CPU frequency (5 V nominal)	0.0914	24	24.6 ^[22]	MHz	Trimmed. Utilizing factory trim values. SLIMO mode = 0.
F _{CPU2}	CPU frequency (3.3 V nominal)	0.0914	12	12.3 ^[23]	MHz	Trimmed. Utilizing factory trim values. SLIMO mode = 0.
F _{48M}	Digital PSoC block frequency	0	48	49.2 ^[22, 24]	MHz	Refer to AC Digital Block Specifications on page 40.
F _{24M}	Digital PSoC block frequency	0	24	24.6 ^[24]	MHz	
F _{32K1}	Internal low speed oscillator (ILO) frequency	15	32	64	kHz	
F _{32K2}	External crystal oscillator	_	32.768	-	kHz	Accuracy is capacitor and crystal dependent. 50% duty cycle.
F _{32K_U}	ILO untrimmed frequency	5	-	100	kHz	After a reset and before the m8c starts to run, the ILO is not trimmed. See the System Resets section of the PSoC Technical Reference Manual for details on timing this
F _{PLL}	PLL frequency	_	23.986	-	MHz	Multiple (x732) of crystal frequency.
t _{PLLSLEW}	PLL lock time	0.5	-	10	ms	
t _{PLLSLEWSLOW}	PLL lock time for low gain setting	0.5	-	50	ms	
tos	External crystal oscillator startup to 1%	_	1700	2620	ms	
tosacc	External crystal oscillator startup to 100 ppm	_	2800	3800	ms	The crystal oscillator frequency is within 100 ppm of its final value by the end of the T_{osacc} period. Correct operation assumes a properly loaded 1 μ W maximum drive level 32.768 kHz crystal. 3.0 V \leq V _{DD} \leq 5.5 V, -40 °C \leq T _A \leq 85 °C.
t _{XRST}	External reset pulse width	10	_	_	μs	
DC _{24M}	24 MHz duty cycle	40	50	60	%	
DC _{ILO}	ILO duty cycle	20	50	80	%	
Step _{24M}	24 MHz trim step size	_	50	_	kHz	
t _{POWERUP}	Time from end of POR to CPU executing code	_	16	100	ms	wer-up from 0 V. See the System Resets section of the PSoC Technical Reference Manual.
Fout _{48M}	48 MHz output frequency	46.8	48.0	49.2 ^[22, 23]	MHz	Trimmed. Utilizing factory trim values.
F _{MAX}	Maximum frequency of signal on row input or row output.	_	_	12.3	MHz	
SR _{POWER_UP}	Power supply slew rate	_	-	250	V/ms	V _{DD} slew rate during power-up.

Notes

^{22.4.75} V < V_{DD} < 5.25 V.
23.3.0 V < V_{DD} < 3.6 V. See application note Adjusting PSoC[®] Trims for 3.3 V and 2.7 V Operation – AN2012 for information on trimming for operation at 3.3 V.
24. See the individual user module datasheets for information on maximum frequencies for user modules.



AC I²C Specifications

Table 39 lists guaranteed maximum and minimum specifications for the voltage and temperature ranges: 4.75 V to 5.25 V and $-40 ^{\circ}\text{C} \leq \text{T}_{A} \leq 85 ^{\circ}\text{C}$, or 3.0 V to 3.6 V and $-40 ^{\circ}\text{C} \leq \text{T}_{A} \leq 85 ^{\circ}\text{C}$, respectively. Typical parameters apply to 5 V and 3.3 V at $25 ^{\circ}\text{C}$ and are for design guidance only.

Table 39. AC Characteristics of the I²C SDA and SCL Pins

Symbol	Description	Standard Mode		Fast Mode		1114
		Min	Max	Min	Max	Unit
F _{SCLI2C}	SCL clock frequency	0	100	0	400	kHz
t _{HDSTAI2C}	Hold time (repeated) start condition. After this period, the first clock pulse is generated.	4.0	_	0.6	-	μS
t _{LOWI2C}	Low period of the SCL clock	4.7	_	1.3	_	μS
t _{HIGHI2C}	High period of the SCL clock	4.0	_	0.6	_	μS
t _{SUSTAI2C}	Set up time for a repeated start condition	4.7	_	0.6	_	μS
t _{HDDATI2C}	Data hold time	0	_	0	_	μS
t _{SUDATI2C}	Data set up time	250	_	100 ^[33]	_	ns
t _{SUSTOI2C}	Set up time for stop condition	4.0	_	0.6	_	μS
t _{BUFI2C}	Bus-free time between a stop and start condition	4.7	_	1.3	_	μS
t _{SPI2C}	Pulse width of spikes are suppressed by the input filter.	_	_	0	50	ns

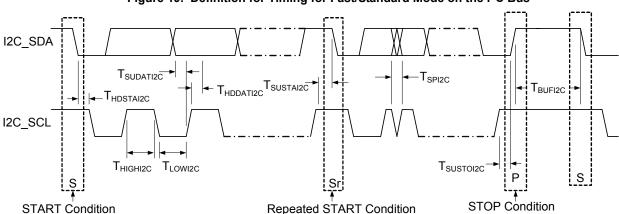


Figure 19. Definition for Timing for Fast/Standard Mode on the I²C Bus

Note

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^{33.} A Fast-Mode I2C-bus device can be used in a Standard-Mode I2C-bus system, but the requirement t_{SU-DAT} ≥ 250 ns must then be met. This is automatically the case if the device does not stretch the LOW period of the SCL signal. If such device does stretch the LOW period of the SCL signal, it must output the next data bit to the SDA line t_{rmax} + t_{SU:DAT} = 1000 + 250 = 1250 ns (according to the Standard-Mode I2C-bus specification) before the SCL line is released.



Figure 21. 20-pin (210-Mil) SSOP

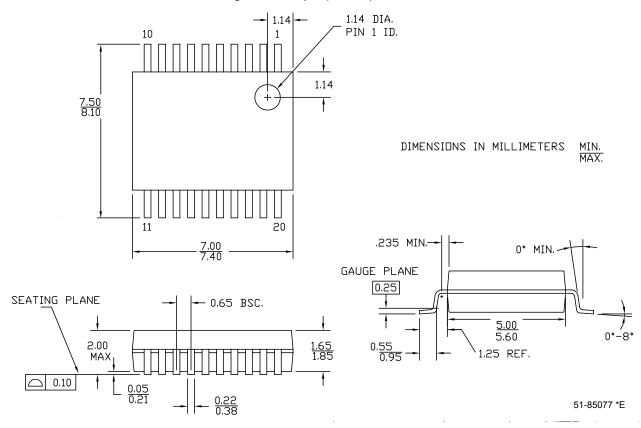




Figure 22. 20-pin SOIC (0.513 × 0.300 × 0.0932 Inches) Package Outline, 51-85024

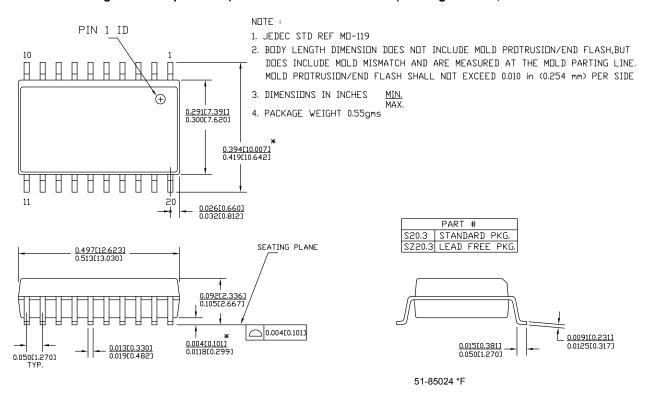
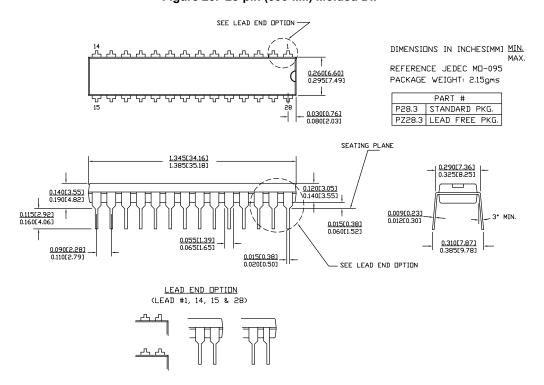


Figure 23. 28-pin (300-Mil) Molded DIP

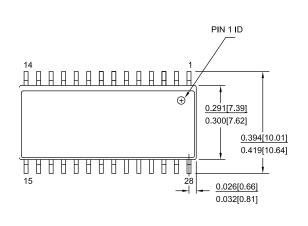


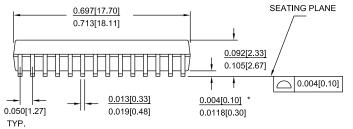
51-85014 *G



Figure 24. 28-pin (210-Mil) SSOP 1.14 DIA. PIN 1 ID. 1.14 7.50 8.10 DIMENSIONS IN MILLIMETERS MAX. 15 10.00 10.40 SEATING PLANE .235 MIN.-0° MIN-- 0.65 BSC. GAUGE PLANE 2.00 <u>1.65</u> 1.85 0.25 0.10

Figure 25. 28-pin SOIC (0.713 × 0.300 × 0.0932 Inches) Package Outline, 51-85026





1. JEDEC STD REF MO-119

1.25 REF-

2. BODY LENGTH DIMENSION DOES NOT INCLUDE MOLD PROTRUSION/END FLASH, BUT DOES INCLUDE MOLD MISMATCH AND ARE MEASURED AT THE MOLD PARTING LINE. MOLD PROTRUSION/END FLASH SHALL NOT EXCEED 0.010 in (0.254 mm) PER SIDE

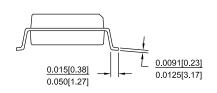
5.00 5.60

51-85079 *E

_ <u>0.55</u> 0.95

3. DIMENSIONS IN INCHES MIN. MAX.

PART#			
S28.3	STANDARD PKG.		
SZ28.3	LEAD FREE PKG.		
SX28.3	LEAD FREE PKG		

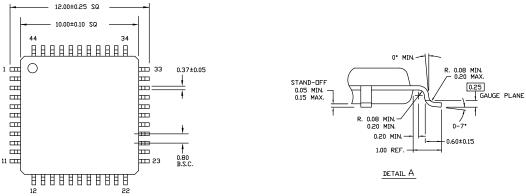


51-85026 *H

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Figure 26. 44-pin TQFP (10 × 10 × 1.4 mm) A44S Package Outline, 51-85064



NDTE:

- SEATING PLANE

 1.60 MAX.

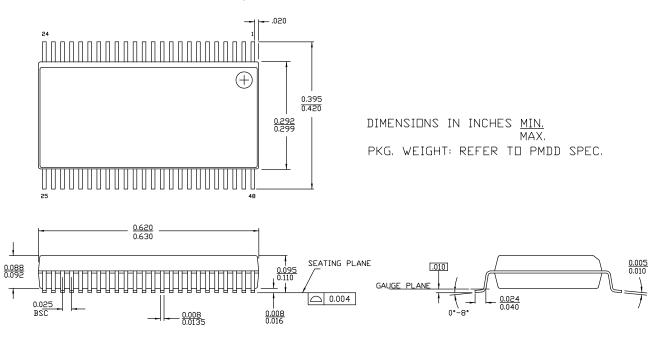
 1.40±0.05

 0.20 MAX.

 SEE DETAILA
- 1. JEDEC STD REF MS-026
- 2. BODY LENGTH DIMENSION DOES NOT INCLUDE MOLD PROTRUSION/END FLASH
 MOLD PROTRUSION/END FLASH SHALL NOT EXCEED 0.0098 in (0.25 mm) PER SIDE
 BODY LENGTH DIMENSIONS ARE MAX PLASTIC BODY SIZE INCLUDING MOLD MISMATCH
- 3. DIMENSIONS IN MILLIMETERS

51-85064 *F

Figure 27. 48-pin (300-Mil) SSOP



51-85061 *F



Development Tool Selection

This chapter presents the development tools available for all current PSoC device families including the CY8C27x43 family.

Software

PSoC Designer™

At the core of the PSoC development software suite is PSoC Designer, used to generate PSoC firmware applications. PSoC Designer is available free of charge at http://www.cypress.com and includes a free C compiler.

PSoC Programmer

Flexible enough to be used on the bench in development, yet suitable for factory programming, PSoC Programmer works either as a standalone programming application or it can operate directly from PSoC Designer or PSoC Express. PSoC Programmer software is compatible with both PSoC ICE-Cube In-Circuit Emulator and PSoC MiniProg. PSoC programmer is available free of charge at http://www.cypress.com.

Development Kits

All development kits can be purchased from the Cypress Online Store.

CY3215-DK Basic Development Kit

The CY3215-DK is for prototyping and development with PSoC Designer. This kit supports in-circuit emulation and the software interface lets you to run, halt, and single step the processor and view the content of specific memory locations. Advance emulation features also supported through PSoC Designer. The kit includes:

- PSoC Designer Software CD
- ICE-Cube In-Circuit Emulator
- ICE Flex-Pod for CY8C29x66 Family
- Cat-5 Adapter
- Mini-Eval Programming Board
- 110 ~ 240 V Power Supply, Euro-Plug Adapter
- iMAGEcraft C Compiler
- ISSP Cable
- USB 2.0 Cable and Blue Cat-5 Cable
- 2 CY8C29466-24PXI 28-PDIP Chip Samples

Evaluation Tools

All evaluation tools can be purchased from the Cypress Online Store.

CY3210-MiniProg1

The CY3210-MiniProg1 kit lets you to program PSoC devices via the MiniProg1 programming unit. The MiniProg is a small, compact prototyping programmer that connects to the PC via a provided USB 2.0 cable. The kit includes:

- MiniProg Programming Unit
- MiniEval Socket Programming and Evaluation Board
- 28-pin CY8C29466-24PXI PDIP PSoC Device Sample
- 28-pin CY8C27443-24PXI PDIP PSoC Device Sample
- PSoC Designer Software CD
- Getting Started Guide
- USB 2.0 Cable

CY3210-PSoCEval1

The CY3210-PSoCEval1 kit features an evaluation board and the MiniProg1 programming unit. The evaluation board includes an LCD module, potentiometer, LEDs, and plenty of breadboarding space to meet all of your evaluation needs. The kit includes:

- Evaluation Board with LCD Module
- MiniProg Programming Unit
- 28-pin CY8C29466-24PXI PDIP PSoC Device Sample (2)
- PSoC Designer Software CD
- Getting Started Guide
- USB 2.0 Cable

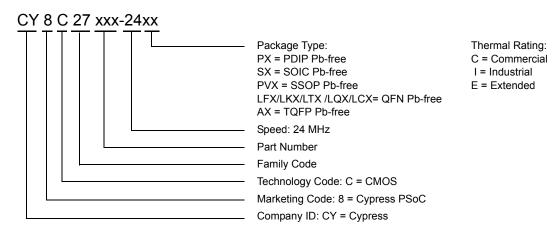
CY3214-PSoCEvalUSB

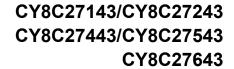
The CY3214-PSoCEvalUSB evaluation kit features a development board for the CY8C24794-24LFXI PSoC device. Special features of the board include both USB and capacitive sensing development and debugging support. This evaluation board also includes an LCD module, potentiometer, LEDs, an enunciator and plenty of breadboarding space to meet all of your evaluation needs. The kit includes:

- PSoCEvalUSB Board
- LCD Module
- MIniProg Programming Unit
- Mini USB Cable
- PSoC Designer and Example Projects CD
- Getting Started Guide
- Wire Pack



Ordering Code Definitions







Glossary (continued)

shift register A memory storage device that sequentially shifts a word either left or right to output a stream of serial data.

slave device A device that allows another device to control the timing for data exchanges between two devices. Or when

devices are cascaded in width, the slave device is the one that allows another device to control the timing of data exchanges between the cascaded devices and an external interface. The controlling device is called the master

device.

SRAM An acronym for static random access memory. A memory device where you can store and retrieve data at a high

rate of speed. The term static is used because, after a value is loaded into an SRAM cell, it remains unchanged

until it is explicitly altered or until power is removed from the device.

SROM An acronym for supervisory read only memory. The SROM holds code that is used to boot the device, calibrate

circuitry, and perform Flash operations. The functions of the SROM may be accessed in normal user code,

operating from Flash.

stop bit A signal following a character or block that prepares the receiving device to receive the next character or block.

synchronous 1. A signal whose data is not acknowledged or acted upon until the next active edge of a clock signal.

2. A system whose operation is synchronized by a clock signal.

tri-state A function whose output can adopt three states: 0, 1, and Z (high-impedance). The function does not drive any

value in the Z state and, in many respects, may be considered to be disconnected from the rest of the circuit,

allowing another output to drive the same net.

UART A UART or universal asynchronous receiver-transmitter translates between parallel bits of data and serial bits.

user modules Pre-build, pre-tested hardware/firmware peripheral functions that take care of managing and configuring the lower

level Analog and Digital PSoC Blocks. User Modules also provide high level API (Application Programming

Interface) for the peripheral function.

user space The bank 0 space of the register map. The registers in this bank are more likely to be modified during normal

program execution and not just during initialization. Registers in bank 1 are most likely to be modified only during

the initialization phase of the program.

 V_{DD} A name for a power net meaning "voltage drain." The most positive power supply signal. Usually 5 V or 3.3 V.

V_{SS} A name for a power net meaning "voltage source." The most negative power supply signal.

watchdog timer A timer that must be serviced periodically. If it is not serviced, the CPU resets after a specified period of time.

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Errata

This section describes the errata for CY8C27143, CY8C27243, CY8C27443, CY8C27543, and CY8C27643 devices. Details include errata trigger conditions, scope of impact, available workaround, and silicon revision applicability. Contact your local Cypress Sales Representative if you have questions.

In Production

Part Numbers Affected

Part Number		
	CY8C27143	
	CY8C27243	
	CY8C27443	
	CY8C27543	
	CY8C27643	

Qualification Status

CY8C27XXX Rev. B - In Production

Errata Summary

The following table defines the errata applicability to available devices.

Items	Part Number	Silicon Revision	Fix Status
Reading from chained SPI slaves does not give correct results.	All parts affected		No silicon fix planned. Workaround is required.
Internal Main Oscillator (IMO) Tolerance Deviation at Temperature Extremes.	All devices		No silicon fix planned. Workaround is required.

1. Reading from chained SPI slaves does not give correct results.

■ Problem Definition

When multiple Digital Communication Blocks are configured as SPI Slave devices and one SPI's output (MISO) is connected to the input (MOSI) of the second SPI, the serial data will be correctly forwarded, but reading the results from the DCBxxDR2 register in the second device will result in the last bit shifted in being incorrect.

■ Parameters Affected

NΑ

■ Trigger Condition

Connection of the output of one PSoC SPI slave to the input of another PSoC SPI slave.

■ Scope of Impact

PSoC end user designs incorporating SPI configurations with multiple Digital Communication Blocks configured as SPI Slave devices with one SPI output (MISO) connected to the input (MOSI) of the second SPI.

■ Workaround

This solution requires the use of an additional digital block configured as a PWM8 set for a 50% duty cycle. The same clock is routed to the PWM8, as goes to the two SPI slaves. The PWM8 User Module is parameterized to have a Period of 15 (so that it divides by 16) and a pulse width of 8 (with CompType set to "Less Than Or Equal" (so that it has a "1" pulse width of 8 clocks and a "0" pulse width of 8 clocks). The output of the PWM8 is connected to the Slave Select (/SS) of each SPI slave. One of these connections is direct. The other connection is inverted using the row output LUT. This configuration will "ping pong" the two SPIs so that each one receives alternating bytes. This solution works especially well in cases where the two SPI slaves are being used to implement a 16-bit shift register, the following method has worked.

■ Fix Status

There are no fixes planned. The workaround listed above should be used.

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2. Internal Main Oscillator (IMO) Tolerance Deviation at Temperature Extremes.

■ Problem Definition

Asynchronous Digital Communications Interfaces may fail framing beyond 0 to 70 °C. This problem does not affect end-product usage between 0 and 70 °C.

■ Parameters Affected

The IMO frequency tolerance. The worst case deviation when operated below 0°C and above +70°C and within the upper and lower datasheet temperature range is ±5%.

■ Trigger Condition(s)

The asynchronous Rx/Tx clock source IMO frequency tolerance may deviate beyond the data sheet limit of \pm 2.5% when operated beyond the temperature range of 0 to +70 °C.

■ Scope of Impact

This problem may affect UART, IrDA, and FSK implementations.

■ Workaround

Implement a quartz crystal stabilized clock source on at least one end of the asynchronous digital communications interface.

■ Fix Status

There are no fixes planned. The workaround listed above should be used.

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